Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/635,489	CHANG ET AL.
	Examiner	Art Unit
	DAMD MI	2010

	SEARCHED					
Class	Subclass	Date	Examiner			
438	149, 162; 166, 482; 485-486	2/10/2005	DV			
	514, 535	2/10/2005	DV			
	795, 914	2/10/2005	DV			
Updated		9/6/2005	DV			
Updated		1/22/2006	DV			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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		DATE	EXMR
EAST	2	V10/2005	DV
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